

Notice of References Cited	Application/Control No. 10/032,694	Applicant(s)/Patent Under Reexamination ANDERTON ET AL.	
	Examiner John B. Sotomayor	Art Unit 3662	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3713156 A	01-1973	Pothier	342/22
	B	US-5081456 A	01-1992	Michiguchi et al	342/22
	C	US-5557108 A	09-1996	Tumer et al	250/390.04
	D	US-5557283 A	09-1996	Sheen et al	342/179
	E	US-6242740 B1	06-2001	Luukanen et al	250/353
	F	US-6353224 B1	03-2003	Sinclair et al	250/336.1
	G	US-6359582 B1	03-2003	MacAleese et al	342/22
	H	US-20020130804 A1	09-2002	McMakin et al	342/22
	I	US-6480141 B1	11-2002	Toth et al	342/22
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-10148673-A	06-1998	JP	Mitsubishi Electric Corp.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Concealed weapon detection using microwave and millimeter wave sensors", McMillan, R.W.; Currie, N.C.; Ferris, D.D., Jr.; Wicks, M.C.; Microwave and Millimeter Wave Technology Proceedings, 1998, p. 1-4
	V	"Signal and image processing for crime control and crime prevention", Hackwood, S.; Potter, P.A.; Image Processing, 1999. ICIP 99, p. 513 -517 vol.3
	W	"FMCW radar for hidden object detection", Olver, A.D.; Cuthbert, L.G.; Radar and Signal Processing [see also IEE Proceeding Radar, Sonar and Navigation], IEE Proceedings F, Volume: 135 Issue: 4, Aug 1988, p. 354 -361
	X	"Privacy algorithm for cylindrical holographic weapons surveillance system", Keller, P.E.; McMakin, D.L.; Sheen, D.M.; McKinnon, A.D.; Summet, J.W.; IEEE Aerospace and Electronics Systems Magazine, Vol. 15 Issue: 2, Feb 2000, p. 17 -24

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.